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Application/Control No.	Applicant(s)/Patent under Reexamination		
10/808,870	INOUE ET AL.		
Examiner	Art Unit		

Nathan Danielsen

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Class	Subclass	Date	Examiner
369	2	11/9/2006	ND
369	4	11/9/2006	ND
381	119	11/9/2006	ND
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INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
					
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Consulted Tan Dinh for search, suggested 369/2, 369/4, and 381/119	11/9/2006	ND		
Search in suggested classes/subclasses	11/9/2006	ND		
Text search (USPAT, US-PGPUB, EPO, JPO, IBM_TDB, and FPRPS)	11/9/2006	ND		
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